

# **5.1. High-Performance Component Strategies to Address Thermal and Frequency Challenges in Base Stations**

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## **ABSTRACT**

Modern telecommunications infrastructure increasingly demands robust component solutions to support the transition from 5G to emerging 6G technologies. This paper examines the critical thermal and frequency challenges facing base station power amplifiers (PAs) and presents comprehensive strategies for optimal capacitor selection. Base station PAs operate under extreme environmental conditions with temperatures reaching 125-150°C, while simultaneously managing frequency ranges extending from sub-6 GHz to millimeter-wave and terahertz bands. The analysis demonstrates how advanced multilayer ceramic capacitor (MLCC) technologies, including high-Q capacitors with enhanced thermal resilience, ultra-low ESR/ESL designs, and compact form factors, address performance limitations in these demanding environments. Through systematic evaluation of thermal management requirements, impedance matching challenges, and space constraints, this work provides engineering guidance for component selection strategies that ensure reliable operation while maintaining signal integrity and power efficiency across next-generation wireless infrastructure.

## **Introduction**

The evolution from 4G to 5G and future 6G networks has fundamentally transformed the requirements for base station power amplifiers, creating unprecedented challenges in thermal management and frequency performance[1]. Modern base station PAs must deliver higher power efficiency while operating across broader frequency ranges, from traditional sub-6 GHz bands to millimeter-wave frequencies extending beyond 30 GHz[2]. The architectural shift toward active antenna units (AAUs) has further complicated design requirements by integrating power supply units (PSUs) with remote radio units (RRUs) in shared thermal environments[3].

Contemporary wireless standards exhibit significantly greater susceptibility to distortion compared to previous generations, necessitating PA operation at levels well below saturation to maintain acceptable signal quality[1]. This operational constraint forces a trade-off where substantial input energy dissipates as heat rather than contributing to transmitted signal power, analogous to operating a high-performance engine at reduced capacity while maintaining fuel consumption rates. The challenge intensifies when considering that base station PAs can account for more than half of total power dissipation in wireless infrastructure[4].

Base station deployment environments present additional thermal stress factors that compound component reliability challenges. Temperature cycling from -70°C to +180°C can induce material failures including solder joint cracking, metal migration, and dielectric layer degradation[5]. Environmental data from operational sites demonstrates extreme temperature variations, with summer peak temperatures reaching 97°F (36°C) and significant daily temperature ranges of 16°F[6]. These conditions, combined with humidity and mechanical stress, create demanding operational environments that require component solutions capable of sustained performance under thermal extremes.

## **Thermal Management Challenges in Modern Base Stations**

The thermal landscape of 5G base stations presents critical challenges that directly impact component selection and system reliability. Recent analysis indicates that 5G systems exhibit substantially higher power consumption compared to previous generation technologies, with first-generation 5G smartphones demonstrating thermal instability during summer operation, often reverting to 4G after mere seconds of 5G operation due to inadequate thermal management [7]. This thermal sensitivity extends throughout the infrastructure ecosystem, from end-user devices to base station equipment. Base station power amplifiers generate substantial heat during operation, with environmental temperatures around PA circuits frequently exceeding 125°C [8][9]. The integration of PSUs with RRUs in modern AAU architectures exacerbates thermal challenges by creating shared thermal environments where PA inefficiency directly impacts PSU operating temperatures. Industry analysis suggests that PSU operating temperatures have increased from approximately 85°C to nearly 100°C due to this architectural integration [3]. This temperature elevation carries significant reliability implications, as the established rule that mean time between failures (MTBF) halves for every 10°C temperature increase suggests potential PSU lifetime reductions of 50-75% [3].

The challenge extends beyond simple temperature management to encompass thermal cycling effects on component performance. MLCC capacitance exhibits strong temperature dependence, with high dielectric constant types showing significant capacitance variation across operating temperature ranges [10]. For power decoupling applications critical to PA stability, these variations can impact circuit performance and require careful component selection to maintain consistent operation across thermal cycles [8]. The presentation data indicates that for 150°C operation, specialized voltage derating becomes necessary, with products like the GRM32DL8EL475KE07 requiring specific derating curves for reliable operation above 125°C [8].

Space constraints in modern base station designs further complicate thermal management strategies. The trend toward smaller, lighter base station equipment reduces available space for heat sinks while component density increases [9]. This spatial limitation requires component solutions that not only withstand elevated temperatures but also minimize self-heating through low ESR characteristics and efficient heat dissipation [8]. The combination of reduced cooling capacity and increased heat generation creates a thermal design challenge that demands advanced component technologies capable of maintaining performance under severe thermal stress.

## High-Frequency Performance Requirements and Signal Integrity

The expansion of wireless communication into higher frequency bands presents fundamental challenges for component performance and signal integrity in base station applications. 6G technology is expected to utilize frequency ranges extending from millimeter-wave bands (30-300 GHz) to terahertz frequencies (300 GHz-3 THz), representing a significant leap beyond current 5G implementations [2]. These frequency increases demand component solutions with correspondingly enhanced high-frequency characteristics, particularly in terms of self-resonant frequency (SRF), quality factor (Q), and parasitic element minimization.

Power amplifier matching networks operating at these elevated frequencies require capacitors with exceptionally high Q values and precise tolerance control to maintain impedance matching accuracy. The GJM and GQM series high Q capacitors address these requirements through copper electrode construction that enables superior high-frequency performance with Q values optimized for VHF, UHF, and microwave frequency bands. For base station PA applications, impedance matching accuracy directly impacts power transfer efficiency and linearity, making high-Q capacitor selection critical for overall system performance [8].

Signal integrity considerations become increasingly critical as frequency increases, with parasitic inductance and resistance having more pronounced effects on circuit behavior. The relationship between capacitor size and high-frequency performance demonstrates clear trade-offs, with smaller case sizes generally exhibiting higher SRF but reduced power handling capability. For example, comparison data between GQM15 (0402) and GQM18 (0603) series shows that while smaller sizes achieve higher operating frequencies, they exhibit increased ESR and reduced power handling capacity (see fig.1). This relationship requires careful optimization between frequency performance and power requirements in PA circuit design.

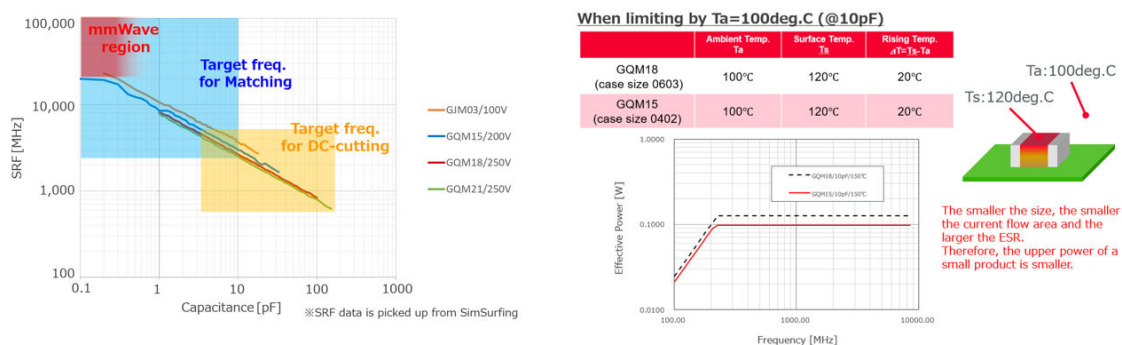


Fig.1. left :capacitor size and its covering frequency range  
right: Calculated power restriction by self-heating comparison GQM15 to GQM18

The challenge of maintaining signal quality across wide bandwidths adds another dimension to component selection requirements. Ultra-wideband base station implementations require capacitors that maintain consistent performance characteristics across broad frequency ranges while supporting various modulation schemes. Temperature compensation becomes particularly important in these applications, as frequency-dependent capacitance variations can cause impedance mismatches that degrade signal quality and increase error vector magnitude (EVM)[11]. Advanced ceramic dielectric formulations, such as the C0G and X8G temperature characteristics available in GJM and GQM series, provide the stability necessary for maintaining signal integrity across temperature and frequency variations [8].

## Advanced MLCC Technologies for Base Station Applications

The evolution of MLCC technology has yielded specialized solutions specifically engineered to address the unique challenges of base station power amplifier applications. High-capacitance GRM series capacitors provide essential power supply decoupling for PA drain voltage supplies, with products like the GRM32/10uF delivering 10uF capacitance in 1210 case size while maintaining 100V rating for 48V GaN amplifier applications. These components enable stable power delivery under dynamic load conditions while occupying minimal board space, addressing the dual challenges of performance and miniaturization in modern base station designs.

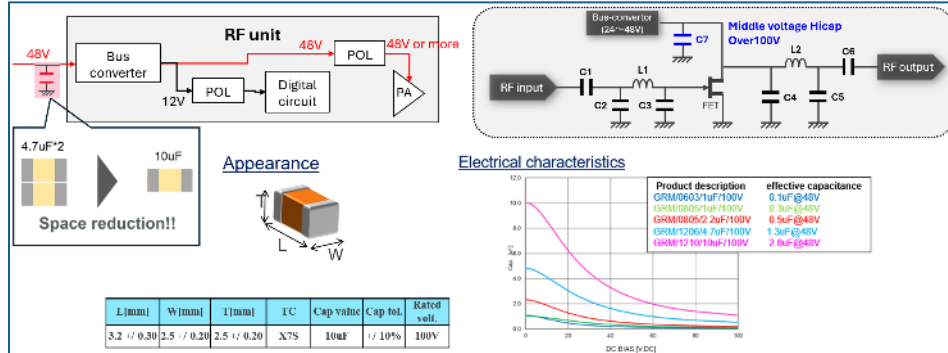


Fig.2 use small size and large capacitance capacitor for space saving

Low ESL (Equivalent Series Inductance) technologies represent a critical advancement for high-frequency decoupling applications. The NFM series three-terminal capacitors achieve ultra-low inductance through innovative internal electrode structures that create multiple current paths and reduced current loop areas[8]. This design approach enables significant impedance reduction at high frequencies, with measured improvements showing substantial noise suppression and voltage stability compared to conventional two-terminal designs[8]. The three-terminal configuration allows both feed-through and non-feed-through mounting options, providing design flexibility for various circuit topologies while maintaining superior high-frequency performance. (see fig.3, fig.4, fig 5)

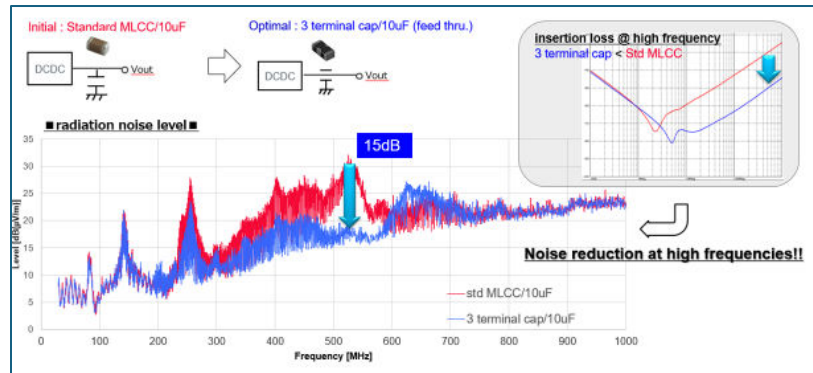


Fig3. Effect by 3 terminal cap: Reducing radiation noise, the radiation noise level will be also reduced by using 3 terminal cap, when the objective power line is noise source.

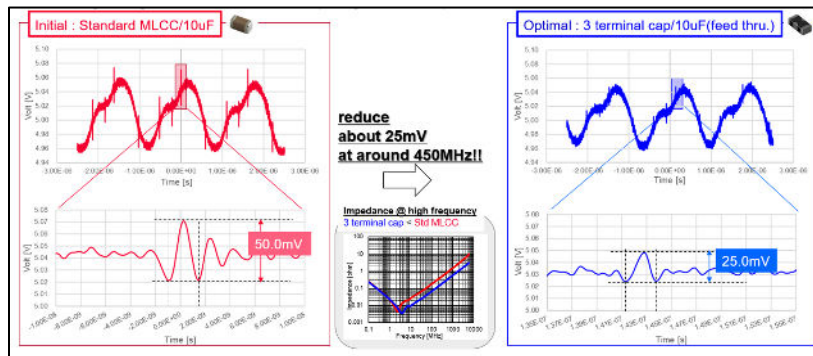


Fig 4. Effect by 3 terminal cap: Reducing radiation noise , The radiation noise level will be also reduced by using 3 terminal cap, when the objective power line is noise source.

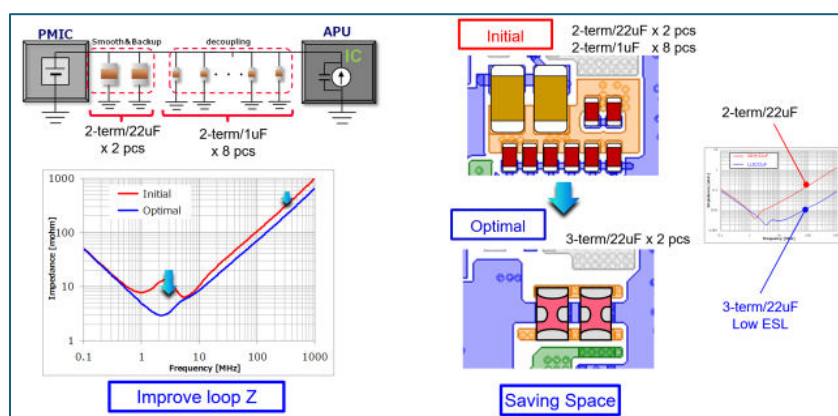


Fig5. Effect by 3 terminal cap: Reducing capacitor count and mounting space

For RF matching and DC-blocking applications, the GJM and GQM series incorporate copper inner electrodes to achieve exceptional Q values and low ESR characteristics essential for high-power PA circuits (see fig.6). The GQM series extends operating voltage capabilities up to 500V, accommodating high-power amplifier requirements while maintaining tight tolerance control necessary for precise impedance matching (see fig.7). These capacitors support temperature compensation in high-frequency circuits where operating characteristics become critically dependent on capacitance stability across environmental variations.

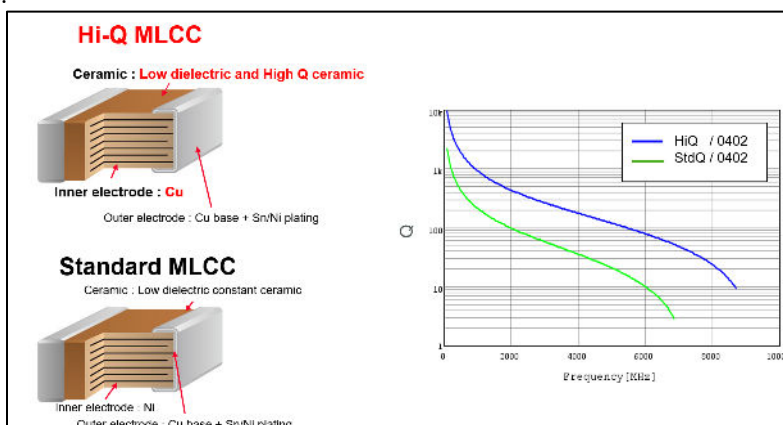


Fig.6 High Q MLCC (GJM, GQM series) vs. Standard MLCC (GRM series)

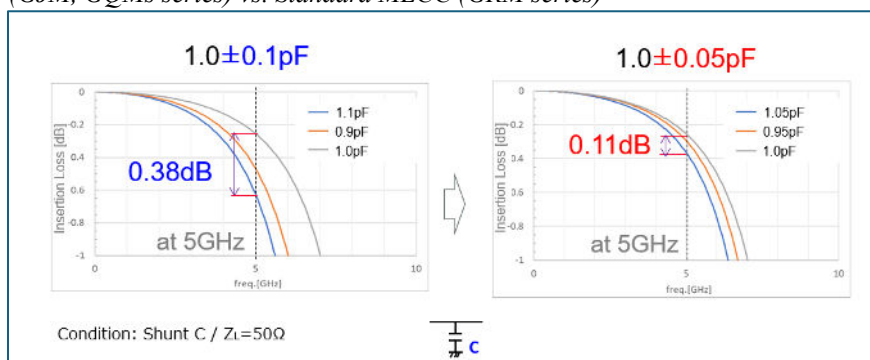


Fig.7 Effect of tight cap tolerance: conventional 0.1pF tol.v.s new 0.05 tol.. Tight capacitance tolerance improves variation of insertion loss at high frequency. using 0.05pF step capacitor, can get the best matching and higher yield!

Thermal resilience improvements in advanced MLCC designs address the extreme temperature environments characteristic of base station operation. The development of 150°C rated products with voltage derating capabilities enables reliable operation in elevated temperature environments while maintaining capacitance stability[8]. For applications requiring operation beyond standard temperature ranges, specialized dielectric formulations such as X8G provide extended temperature capability to 150°C with minimal capacitance drift, ensuring consistent circuit performance across environmental extremes. (See Fig.7)



Fig.7 150°C rated products with voltage derating capabilities enables reliable operation in elevated temperature environments while maintaining capacitance stability

## Design Optimization and Component Selection Strategies

Effective component selection for base station applications requires careful consideration of multiple performance parameters and their interactions under actual operating conditions. The selection process must balance electrical performance, thermal characteristics, physical constraints, and reliability requirements to achieve optimal system-level performance.

Thermal design considerations begin with understanding the actual operating environment around power amplifier circuits. Components located near high-power transistors may experience temperatures significantly above ambient conditions, requiring careful thermal modeling to determine appropriate temperature ratings<sup>[9]</sup>. The 150°C operational capability of advanced MLCC technologies provides essential design margin for these challenging environments, enabling reliable operation even under worst-case thermal conditions<sup>[9]</sup>.

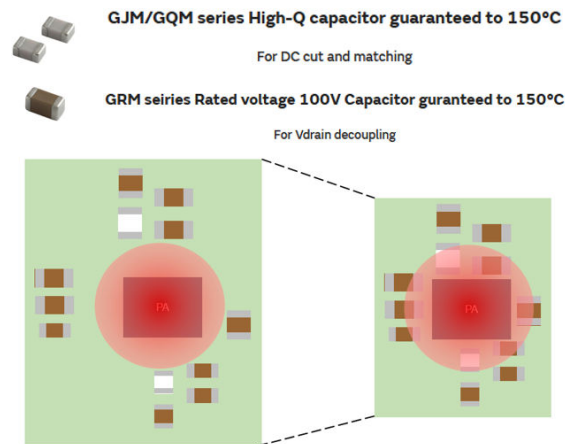


Fig.8. Capacitor solution that can be used where temp. exceed 125°C near the PA circuit and in high temp. environments

Frequency response optimization requires matching component characteristics to specific circuit functions and operating frequencies. For DC blocking applications in 5.9 GHz DSRC, 5G systems, capacitors with self-resonant frequencies well above the operating frequency ensure proper capacitive behavior throughout the frequency band. The selection of appropriate capacitance values must consider not only the desired impedance characteristics but also the impact on SRF and Q factor performance.

Size optimization strategies focus on achieving maximum performance within constrained physical dimensions. The availability of high-Q capacitors in 0201 and smaller package sizes enables higher circuit density while maintaining superior electrical performance<sup>[9]</sup>. This miniaturization capability is particularly important in modular PA designs, where space constraints require innovative approaches to component placement and thermal management. (see fig.9)

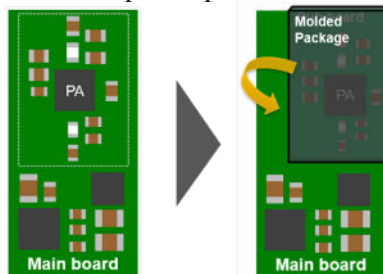


Fig 9. Murata's High-Q capacitor lineup includes sizes from 0402 down to 0201. Our special design achieves higher Q values than standard GRM series, even at low capacitance. These compact, high-Q components enable denser high-frequency PA circuits.

Component count reduction through the use of higher-performance capacitors can significantly improve system reliability and reduce manufacturing costs. Large-capacitance MLCCs enabling integration of multiple discrete components into single packages, while advanced tolerance specifications reduce the need for selection and tuning during manufacturing<sup>[9]</sup>. The recently introduced 100  $\mu\text{F}$  capacitors in 0603 packages demonstrate the potential for dramatic space savings in power management applications<sup>[12]</sup>.

ESR and ESL optimization requires careful consideration of package geometry and internal construction. Low-inductance designs with optimized terminal configurations minimize parasitic effects that can degrade high-frequency performance<sup>[8]</sup>. The equivalent series inductance (ESL) becomes particularly important in high-current applications, where inductive voltage drops can cause significant performance degradation.

Current handling capability must be evaluated based on both thermal and electrical stress considerations. High-Q capacitors designed for base station applications incorporate specialized geometries and materials that enable higher current densities without performance degradation. This capability is essential for matching networks in high-power amplifiers, where RF currents can reach substantial levels.

## Conclusion

The transition to 5G and 6G base stations brings new challenges in component selection and circuit design. Modern ceramic capacitors featuring thermal resilience, superior high-frequency performance, and compact size are key enabling technologies for telecom infrastructure. These components demand careful consideration of thermal, electrical, and mechanical requirements. With temperature ratings up to 150°C, optimized Q factors, and precise tolerances, they enable advanced circuit designs beyond conventional capabilities.

Future ceramic capacitor development will target smaller sizes with better performance, higher temperature capabilities, and specialized formulations for new frequency bands. These advances will support the growing demands of telecom infrastructure.

Selecting the right high-performance ceramic capacitors is crucial for meeting base station performance and reliability goals. These components will become increasingly vital for global connectivity infrastructure.

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